

IGBT module high-power & increased rated insulation voltage 10.2 kV

3300 V 1500 A


Chip features

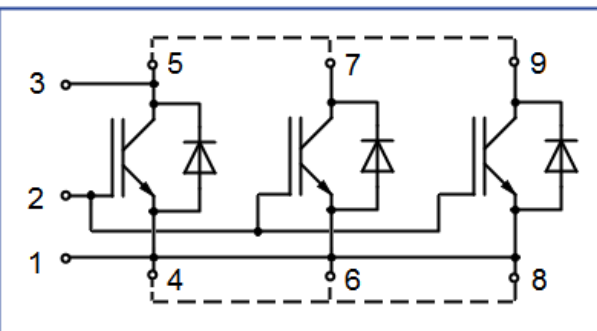
- IGBT chip
 - SPT+
 - low $V_{CE(sat)}$ value
 - low EMI
 - fast and soft reverse recovery

Design features

- AlSiC baseplate
- AlN DBC substrate
- ultrasonically welded power terminals
- high rated insulation voltage – 10200 V
- RoHS compliant

Typical application

- transport (auxiliary power systems for rail and public transport)
- industrial equipment



Maximum rated values

Definition	Symbol	Conditions	Value	Unit
IGBT				
Collector-Emitter voltage	V_{CES}	$V_{GE} = 0$.	3300	V
Collector current (nominal)	$I_{C\ nom}$	$T_c = 80^\circ\text{C}$	1500	A
Repetitive peak collector current ^{*1}	I_{CRM}	$I_{CRM} = 2 \times I_{C\ nom}$; $t_p = 1\ \text{ms}$.	3000	A
Short-circuit duration	t_{psc}	$T_{vj} = 150^\circ\text{C}$; $V_{GE} = \pm 15\ \text{V}$; $V_{CE} = 2500\ \text{V}$; $I_{C\ max} < 5500\ \text{A}$.	10	μs
Gate-Emitter voltage	V_{GES}		± 20	V
Junction operating temperature	$T_{vj\ (op)}$		-40...+150	$^\circ\text{C}$
Inverse diode \ Freewheeling diode				
Repetitive peak reverse voltage	V_{RRM}	$V_{GE} = 0\ \text{V}$.	3300	V
Forward current (nominal)	$I_{F\ nom}$		1500	A
Repetitive peak forward current ^{*1}	I_{FRM}	$I_{FRM} = 2 \times I_{F\ nom}$; $t_p = 1\ \text{ms}$.	3000	A
Junction operating temperature	$T_{vj\ (op)}$		-40...+150	$^\circ\text{C}$
Module				
Storage temperature	T_{stg}		-50...+50	$^\circ\text{C}$
Isolation voltage	V_{isol}	AC sin 50 Hz; $t = 1\ \text{min}$.	10200	V

^{*1} Pulse width and repetition rate should be such that device junction temperature does not exceed maximum T_{vj} rating



Characteristics

Definition	Symbol	Conditions	Value			Unit	
			min.	typ.	max.		
IGBT							
Collector-Emitter saturation voltage	V_{CEsat}	$V_{GE} = +15\text{ V}; I_C = 1500\text{ A};$ $t_u = 1000\text{ }\mu\text{s}.$	$T_{vj} = 25^\circ\text{C}$	-	2.00	-	V
			$T_{vj} = 150^\circ\text{C}$	-	2.90	-	V
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C = 120\text{ mA}; V_{CE} = V_{GE}; T_{vj} = 25^\circ\text{C};$ $t_u = 2\text{ ms}.$	-	5.70	-	-	V
Collector-Emitter cut-off current	I_{CES}	$V_{CE} = 3300\text{ V};$ $t_u = 50\text{ ms}; V_{GE} = 0.$	$T_{vj} = 25^\circ\text{C}$	-	1.00	-	mA
			$T_{vj} = 150^\circ\text{C}$	-	90.00	-	mA
Gate-Emitter leakage current	I_{GES}	$V_{CE} = 0; V_{GE} = \pm 20\text{ V}; T_{vj} = 25^\circ\text{C};$ $t_u = 30\text{ ms}$	-	1.00	-	-	μA
Input capacitance	C_{ies}	$f = 1\text{ MHz}; T_{vj} = 25^\circ\text{C}.$	-	260	-	-	nF
Reverse transfer capacitance	C_{res}		-	6.00	-	-	nF
Total gate charge	Q_G	$I_C = 1500\text{ A}; V_{CE} = 1800\text{ V};$ $V_{GE} = -15\div 15\text{ V}.$	-	15.00	-	-	μC
Turn-on delay time	$t_{d(on)}$	$V_{CE} = 1800\text{ V};$ $V_{GE} = \pm 15\text{ V};$ $I_{C\text{ max}} = 1500\text{ A};$ $R_{G\text{ on}} = 1.5\text{ }\Omega;$ $R_{G\text{ off}} = 1.5\text{ }\Omega;$ $C_{GE} = 330\text{ nF};$ $L = 150\text{ nH}.$	$T_{vj} = 25^\circ\text{C}$	-	960	-	μs
Rise time	t_{ri}		$T_{vj} = 150^\circ\text{C}$	-	-	-	
			$T_{vj} = 25^\circ\text{C}$	-	430	-	μs
Turn-on energy	E_{on}		$T_{vj} = 150^\circ\text{C}$	-	-	-	
			$T_{vj} = 25^\circ\text{C}$	-	2400	-	mJ
Turn-off delay time	$t_{d(off)}$		$T_{vj} = 150^\circ\text{C}$	-	-	-	
			$T_{vj} = 25^\circ\text{C}$	-	2700	-	μs
Fall time	t_{fi}		$T_{vj} = 150^\circ\text{C}$	-	-	-	
			$T_{vj} = 25^\circ\text{C}$	-	610	-	μs
Turn-off energy	E_{off}		$T_{vj} = 150^\circ\text{C}$	-	-	-	
			$T_{vj} = 25^\circ\text{C}$	-	3750	-	mJ
Collector-emitter threshold voltage	V_{CE0}		$V_{GE} = +15\text{ V}; T_{vj} = 150^\circ\text{C};$	-	1.13	-	
On-State slope resistance (IGBT)	r_{CE0}	$I_{CE1} = 75\text{ A}; I_{CE2} = 300\text{ A};$ $t_u = 1000\text{ }\mu\text{s}.$	-	6.05	-	-	m Ω
Thermal resistance junction to case	$R_{th(j-c)}$	DC; $I_{CE} = 900\pm 10\text{ A}; I_{test} = 3\text{ A};$ $V_{GE} = +15\text{ V}.$	-	0.008	-	-	K/W
Inverse diode \ Freewheeling diode							
Forward voltage drop	V_F	$I_F = 1500\text{ A};$ $V_{GE} = 0; t_u = 500\text{ }\mu\text{s}.$	$T_{vj} = 25^\circ\text{C}$	-	2.40	-	V
			$T_{vj} = 150^\circ\text{C}$	-	2.50	-	V
Peak reverse current	I_{RM}	$V_{CE} = 1800\text{ V};$ $I_F = 1500\text{ A};$ $di_F/dt = 4000\text{ A}/\mu\text{s}$	$T_{vj} = 25^\circ\text{C}$	-	920	-	A
			$T_{vj} = 150^\circ\text{C}$	-	-	-	A
Recovered charge	Q_r		$T_{vj} = 25^\circ\text{C}$	-	850	-	μC
			$T_{vj} = 150^\circ\text{C}$	-	-	-	μC
Reverse recovery energy	E_{rec}		$T_{vj} = 25^\circ\text{C}$	-	1000	-	J
			$T_{vj} = 150^\circ\text{C}$	-	-	-	J
Thermal resistance junction to case	$R_{th(jc-D)}$	DC; $I_{CE} = 900\pm 20\text{ A}; I_{test} = 3\text{ A};$ $V_{GE} = +15\text{ V}.$	-	0.016	-	-	K/W



Module						
Parasitic inductance between terminals	L_{Pxy}	$T_{vj} = 25^{\circ}\text{C}; f = 1 \text{ MHz}$	-	11.00	-	nH
Thermal resistance case to heatsink	R_{thCH}	per module	-	0.006	-	K/W
Mounting torque for screws to heatsink	M_s	to heatsink M6	-	-	5.00	N*m
Mounting torque for terminal screws	M_t	to terminals M8	-	-	9.00	N*m
Mounting torque for gate terminal	M_t	to terminals M4	-	-	2.00	N*m
Weight	W		-	1700	-	kg

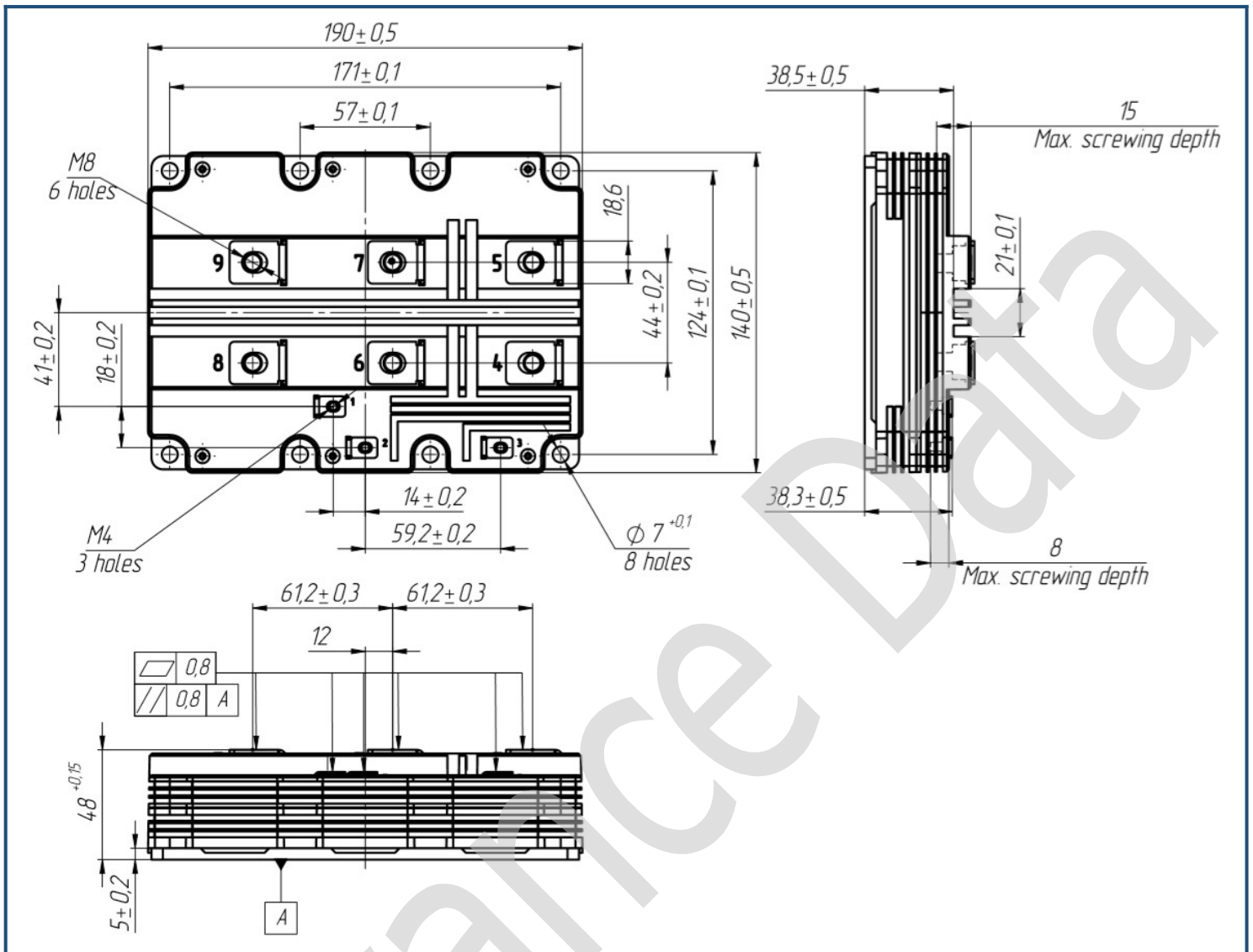
" - " Data will be refined as additional tests are conducted and statistics are collected.

Notes:

- Insulating material operating temperature 125°C max;
- The recommended operating junction temperature $T_{vj\text{ op}} = -40 \div +150^{\circ}\text{C}$.



Overall dimensions: Package type – HV



Part numbering guide

MIHV	-	SS	33	SG	-	1500	N	
MIHV								IGBT module package type: HV
		SS						Single switch
			33					Voltage rating ($V_{CES}/100$)
				SG				IGBT+FRD chipset modification
						1500		Current Rating
							N	Climatic version: normal climate

The information contained herein is protected by Copyright. In the interest of product improvement, Proton-Electrotex reserves the right to change datasheet without notice.